Docket No.: OGOSH54USA

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application No. : 10/595,856 Confirmation No. 7985

Applicant : Haoshen Zhou et al.

371(c) Date : May 16, 2005

Art Unit :

Examiner :

Customer No. : 00270

Title : NANOCRYSTAL OXIDE/GLASS COMPOSITE

MESOPOROUS POWDER OR THIN FILM, PROCESS FOR PRODUCING THE SAME, AND UTILIZING THE POWDER

OR THIN FILM, VARIOUS DEVICES, SECONDARY

BATTERY AND LITHIUM STORING DEVICE

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

## Dear Sir:

In compliance with their duty to disclose under 37 CFR §1.56(a), Applicants and their attorneys enclose a form PTO-1449 and copies of the foreign and other documents listed therein.

The listed references were cited in the International Search Report for International Application No. PCT/JP04/16981 or are related U.S. patent documents.

The Examiner is respectfully requested to consider the cited documents and to make the same of record in the file of the present application.

In the event that a fee for the Information Disclosure Statement is required, please charge the fee to our Deposit Account No. 08-3040.

Respectfully submitted, HOWSON AND HOWSON Attorneys for Applicant

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Form PTO-1449 U.S. Patent and Trademark Office INFORMATION DISCLOSURE STATEMENT		Atty. Docket No. OGOSH54USA		Serial No. <b>10/595,856</b>		
		Applicant: Haoshen Zhou et al.				
		371 (c) Date: May 16, 2006		Group Art Unit:		
	U.S. PA	TENT DOC	UMENTS			
Examiner Initial	Document No.	Date	Name	;	Class	Subclass
	5,622,684	4/1997	Pinnavaia	et al.	423	702
	5,795,559	8/1998	Pinnavaia	et al.	423	702
	2003/0054954 A1	3/2003	Chane-Chin	g et al.	502	304
	FOREIGN	PATENT D	OCUMENTS			
Examiner Initial	Document No.	Date	Country	Translation Yes No		
	JP 2001-233615	8/2001	Japan	Abstract only X		7 X
	JP 2002-338228	11/2002	Japan			7 X
	JP 2002-042808	2/2002	Japan			7 X
	JP 2004-214116	7/2004	Japan			7 X
	JP 2003-077541	3/2003	Japan			/ X
	JP 2003-077466	3/2003	Japan	Abstract only		/ X
Othe	er Documents (including	Author, Titl	e, Date, Pertir	nent Page	es, Etc.)	

<sup>\*</sup>Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

**Date Considered** 

Examiner